SHIGA7.040APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hayashi et al.

Appl. No. : 10/561,830

Filed: December 22, 2005

For : POSITIVE RESIST

COMPOSITION AND METHOD

OF FORMING RESIST PATTERN

USING SAME

Examiner : Thompson Rummel, P.

Group Art Unit : 1795

AMENDMENT AND RESPONSE TO FINAL OFFICE ACTION

Mail Stop AF

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the final Office Action mailed July 18, 2008, please consider the following amendments and remarks:

Amendments to the claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 8 of this paper.